Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/900,379	WONG ET AL.
	Examiner	Art Unit
	F. Pierre VanderVegt	1644

ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
530	395	530	324	325	326	327	328	391.1	391.7
INTERNATIONAL CLASSIFICATION		530	402	868					
C 07 K 7/00									
C 07 K 14/74									
C 07 K 17/02									
/									
/									

f. Pierre VanderVegt 10/03/05
(Assistant Examiner) (Date)

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SUPERVISORY PATENT EXAMINER
(Primary Examiner) TECHNOLOGY CENTER 1600
10/3/05

Total Claims Allowed: 10

O.G. Print Claim(s)	O.G. Print Fig.
1	none

Eileen Amaeeum 10-12-05
(Legal Instruments Examiner) (Date)

☒ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
	1		31	8	61		91		121		151		181
	2		32	9	62		92		122		152		182
	3		33	10	63		93		123		153		183
	4		34		64		94		124		154		184
	5		35		65		95		125		155		185
	6		36		66		96		126		156		186
	7		37		67		97		127		157		187
	8		38		68		98		128		158		188
	9		39		69		99		129		159		189
	10		40		70		100		130		160		190
	11		41		71		101		131		161		191
	12		42		72		102		132		162		192
	13		43		73		103		133		163		193
	14		44		74		104		134		164		194
	15		45		75		105		135		165		195
	16		46		76		106		136		166		196
	17		47		77		107		137		167		197
	18		48		78		108		138		168		198
	19		49		79		109		139		169		199
	20		50		80		110		140		170		200
	21	1	51		81		111		141		171		201
	22	2	52		82		112		142		172		202
	23	3	53		83		113		143		173		203
	24	4	54		84		114		144		174		204
	25		~~55~~		85		115		145		175		205
	26	5	56		86		116		146		176		206
	27		~~57~~		87		117		147		177		207
	28		~~58~~		88		118		148		178		208
	29	6	59		89		119		149		179		209
	30	7	60		90		120		150		180		210